

<b>Notice of References Cited</b>	Application/Control No. 10/043,329	Applicant(s)/Patent Under Reexamination BAEK ET AL.	
	Examiner Steven H. Rao	Art Unit 2814	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,529,282	03-2003	Stirton et al.	356/630
	B	US-6,573,986	06-2003	Smith et al.	356/124
	C	US-6,620,557	09-2003	Hosono et al.	430/5
	D	US-6,656,644	12-2003	Hasegawa et al.	430/5
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.